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## Amendments to the Claims:

This listing of claims will replace all prior versions, and listings of claims in the application.

HENSLEY KIM & EDGINGTON,

## Listing of Claims:

1. (Original) A method of managing spatially related defects on a data storage media surface in a data storage device comprising:

identifying defect locations on the media surface;

determining whether the location of an identified defect is within a predetermined window of another identified defect location on the media surface;

if the location is within the predetermined window, characterizing the defects in the window as a scratch; and.

generating a scratch tracking table having a start index and an end index for each scratch.

- 2. (Original) The method according to claim 1 further comprising padding the scratch.
- 3. (Original) The method according to claim 1 wherein the characterizing operation comprises:

assigning a unique scratch index to the scratch; and associating each defect within the window with the unique scratch index.

- 4. (Original) The method according to claim 3 further comprising: generating a scratch index table associating each identified defect with a scratch index.
- 5. (Original) The method according to claim 1 wherein the determining operation comprises:

loading an identified defect location in a register; and comparing the defect location and a last identified defect location of each identified scratch against predetermined window criteria.

6. (Original) The method according to claim 7 wherein the predetermined window criteria comprises a number of cylinders and a number of bytes.

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7. (Original) A method comprising:

identifying defect locations on a data storage media;

tabulating the identified defects in a defect list;

determining whether one or more defect locations lies within a predetermined window of another defect location;

assigning a unique scratch index to each defect location within the predetermined window;

generating a scratch tracking table listing a start index for a first defect location in the window and an end index for a last defect location in the window for each scratch index assigned; and

generating a scratch index table associating a scratch index with each defect location.

- 8. (Original) The method according to claim 7 further comprising:
  using the scratch tracking table and the scratch index table to determine whether a read or
  write command is to be redirected to another data storage media location.
- 9. (Original) The method according to claim 7 further comprising: retrieving an entry in the scratch tracking-table having a first scratch index; searching the scratch index table for defect locations associated with the first scratch index;

padding the scratch; and repeating the retrieving, searching and padding operations for a next scratch index.

- 10. (Original) The method according to claim 9 wherein the repeating operation includes a query operation asking whether an end of the scratch tracking table has been reached prior to retrieving the next scratch index.
- 11. (Original) A system for managing scratches on a data storage media in a data storage device comprising:

a controller adapted to control access by a host to and from the data storage media; a memory coupled to the controller;

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a scratch index table in the memory having a unique index entry for each identified defect location on the data storage media and an associated scratch index entry for each defect location; and:

a scratch tracking table in the memory having, for each scratch index entry, a start index, and end index, and an end defect location for each identified scratch index.

- 12. (Original) The system according to claim 11 further comprising a buffer in the controller wherein the scratch tracking table and scratch index table are utilized in the buffer to identify defect locations.
- 13. (Currently Amended) The system according to claim 11-further comprisings, wherein the controller

an operational sequence for identifying identifies defect locations on the media surface[[;]],

an operational sequence for determining determines whether the location of an identified defect is within a predetermined window of another identified defect location on the media surface[[;]],

an operational sequence for characterizing characterizes the defects in the window as a scratch, if the location is within the predetermined window[[;]], and

en operational sequence for generating-generates a scratch tracking table having a start index and an end index for each scratch.

- 14. (Currently Amended) The system according to claim 13-further comprising an operational sequence-for padding, wherein the controller pads each scratch in the scratch tracking table.
- 15. (Currently Amended) The system according to claim 13 wherein the characterizing operational sequence comprises controller characterizes the defects by:

assigning a unique scratch index to the scratch[[;]], and associating each defect within the window with the unique scratch index.

16-20. (Cancelled)

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- 22. (New) The method according to claim 21, wherein the scratch index table associates each of the defects with one or more scratches in the medium.
- 23. (New) The method according to claim 21, wherein a scratch includes one or more defects within a predetermined window of another identified defect.
  - 24. (New) The method according to claim 21, wherein the medium is a disc drive.
- 25. (New) The method according to claim 1 wherein the predetermined window criteria comprises a number of cylinders and a number of bytes.